

**Notice of References Cited**

Application/Control No.

10/780,774

Applicant(s)/Patent Under  
Reexamination  
SHIRAKAWA ET AL.

Examiner

Tu M. Nguyen

Art Unit

3748

Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,470,674	10-2002	Yamaguchi et al.	60/277
*	C	US-7,131,261	11-2006	Wackerow et al.	60/277
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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